

Single N-Channel MOSFET

DESCRIPTION

SMC3206PA is the N-Channel enhancement mode power field effect transistors, provide superior fast switching performance and withstand high energy pulse in the avalanche and commutation mode.

PART NUMBER INFORMATION

SMC 3206 PA - TR G
 a b c d e

a : Company name.
 b : Product Serial number.
 c : Package code PA:DFN5X6A-8
 d : Handling code TR:Tape&Reel
 e : Green produce code G:RoHS Compliant

FEATURES

$V_{DS}=30V, I_D=80A$

$R_{DS(ON)}=2.7m\Omega(Typ.)@V_{GS}=10V$

$R_{DS(ON)}=3.4m\Omega(Typ.)@V_{GS}=4.5V$

- ◆ High power and current handling capability
- ◆ 100% EAS Guaranteed

APPLICATIONS

- ◆ DC/DC Converter
- ◆ Power Management



ABSOLUTE MAXIMUM RATINGS ($T_A=25^{\circ}C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-Source Voltage	30	V
V_{GSS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current *	$T_C=25^{\circ}C$	80
		$T_C=100^{\circ}C$	59
I_{DM}	Pulsed Drain Current ^B	280	A
I_D	Continuous Drain Current	$T_A=25^{\circ}C$	22
		$T_A=70^{\circ}C$	17.5
P_D	Power Dissipation ^A	$T_A=25^{\circ}C$	2.5
		$T_A=70^{\circ}C$	1.6
I_{AS}	Single Pulse Avalanche Current ^B	45	A
E_{AS}	Single Pulse Avalanche energy $L=0.1mH$ ^{BE}	101	mJ
P_D	Power Dissipation ^C	$T_C=25^{\circ}C$	46
		$T_C=100^{\circ}C$	18.5
T_J	Operation Junction Temperature	-55/150	$^{\circ}C$
T_{STG}	Storage Temperature Range	-55/150	$^{\circ}C$

THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^A	$t \leq 10s$	20	$^{\circ}C/W$
	Thermal Resistance Junction to Ambient ^{AC}	Steady-State	50	
$R_{\theta JC}$	Thermal Resistance Junction to Case		2.7	

ELECTRICAL CHARACTERISTICS ($T_A=25^{\circ}\text{C}$ Unless otherwise noted)

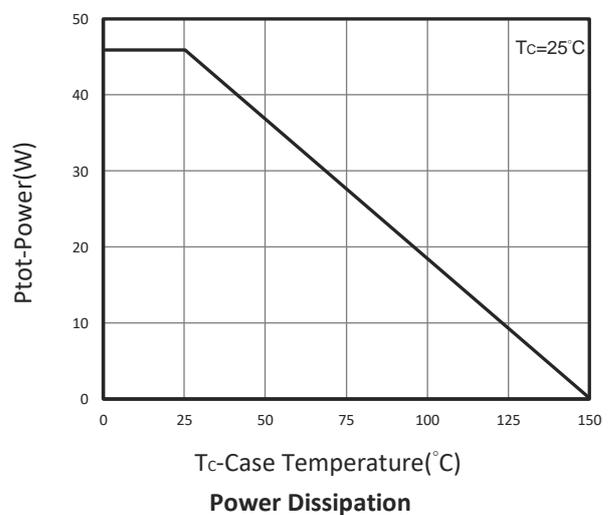
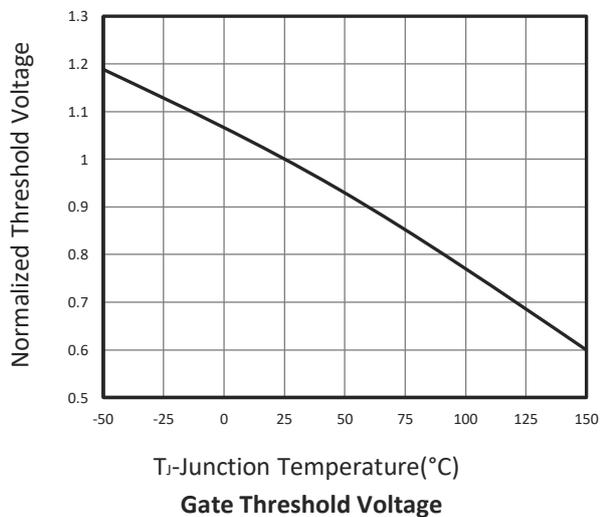
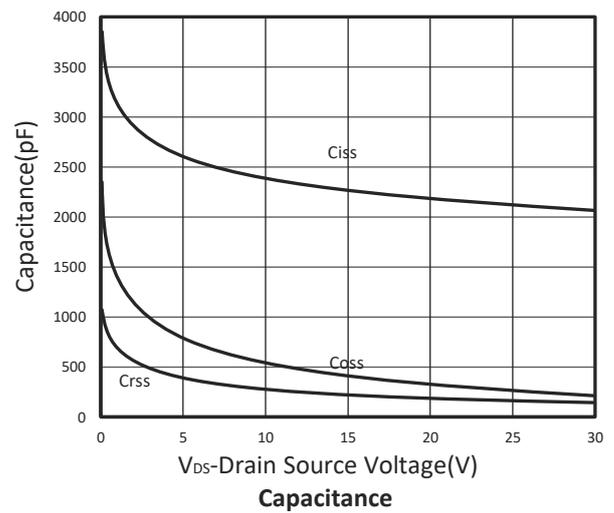
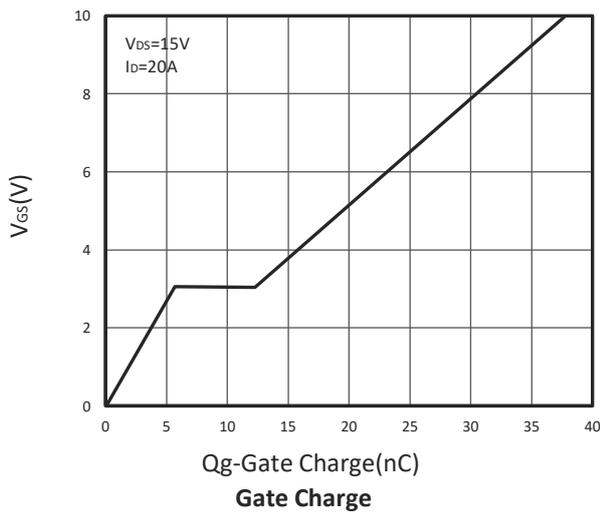
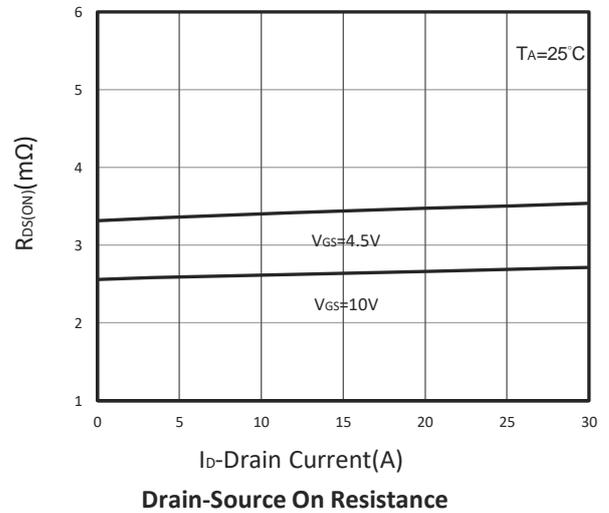
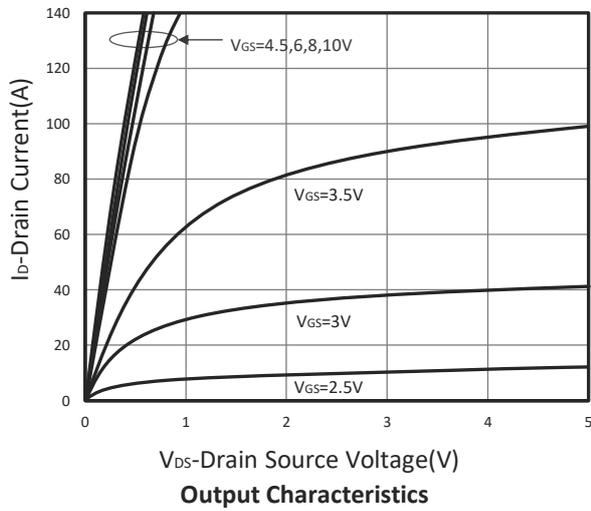
Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Parameters						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.2	1.6	2.5	V
I_{GSS}	Gate Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$			± 100	nA
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V, T_J=25^{\circ}\text{C}$			-1	μA
		$V_{DS}=24V, V_{GS}=0V, T_J=75^{\circ}\text{C}$			-10	
$R_{DS(ON)}$	Drain-source On-Resistance ^D	$V_{GS}=10V, I_D=20A$		2.7	3.2	m Ω
		$V_{GS}=4.5V, I_D=15A$		3.4	4.2	
G_{fs}	Forward Transconductance	$V_{DS}=5V, I_D=20A$		72		S
Diode Characteristics						
V_{SD}	Diode Forward Voltage ^D	$I_S=1A, V_{GS}=0V$			1	V
I_S	Diode Continuous Forward Current				80	A
t_{rr}	Reverse Recovery Time	$I_S=20A, di/dt=100A/\mu s$		34		ns
Q_{rr}	Reverse Recovery Charge			25		nC
Dynamic and Switching Parameters ^F						
Q_g	Total Gate Charge	$V_{DS}=15V, V_{GS}=10V, I_D=20A$		37.5	52.5	nC
Q_g	Total Gate Charge (4.5V)			17.5	24.5	
Q_{gs}	Gate-Source Charge			5.4	7.6	
Q_{gd}	Gate-Drain Charge			6.7	9.4	
C_{iss}	Input Capacitance	$V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$		2250		pF
C_{oss}	Output Capacitance			315		
C_{rss}	Reverse Transfer Capacitance			168		
R_g	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, f=1\text{MHz}$		2		Ω
$t_{d(on)}$	Turn-On Time	$V_{DD}=15V, V_{GS}=10V, R_G=3\Omega, I_D=1A$		8		nS
t_r				5		
$t_{d(off)}$	Turn-Off Time			23		
t_f				9		

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

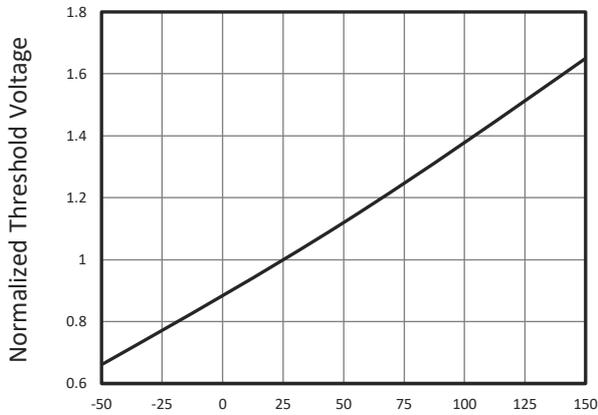
- A. Surface mounted on FR4 board using 1 in² pad size.
- B. Pulsed width limited by maximum junction temperature, $T_{J(MAX)}=150^{\circ}\text{C}$ (initial temperature $T_J=25^{\circ}\text{C}$).
- C. Using $\leq 10\text{s}$ junction-to-ambient thermal resistance is base on $T_{J(MAX)}=150^{\circ}\text{C}$.
- D. Pulse test width $\leq 300\mu\text{s}$ and duty cycle $\leq 2\%$.
- E. The EAS data shows maximum, The test condition is $V_{DD}=25V, V_{GS}=10V, L=0.1\text{mH}, I_{AS}=45A$
- F. Guaranteed by design, not subject to production testing.
- * . The maximum rating current is limited by bonding wire.

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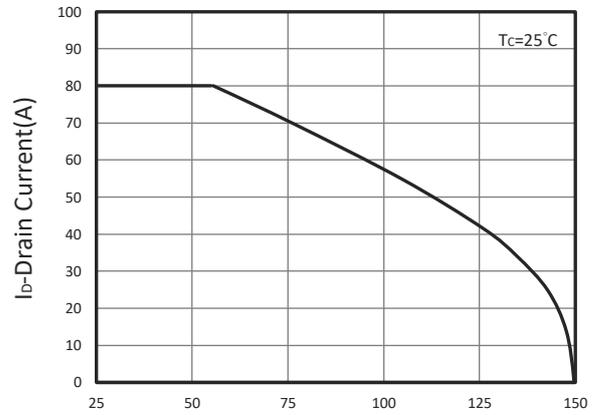
TYPICAL CHARACTERISTICS



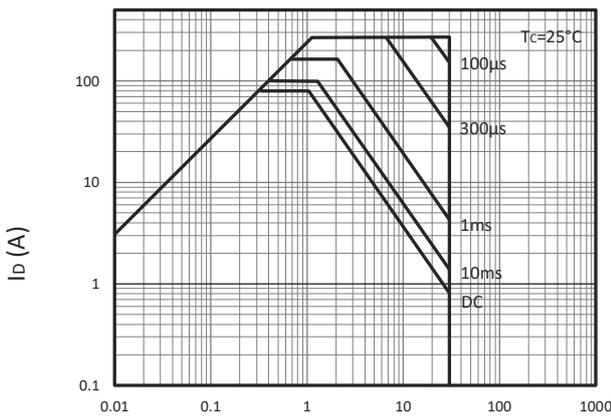
TYPICAL CHARACTERISTICS



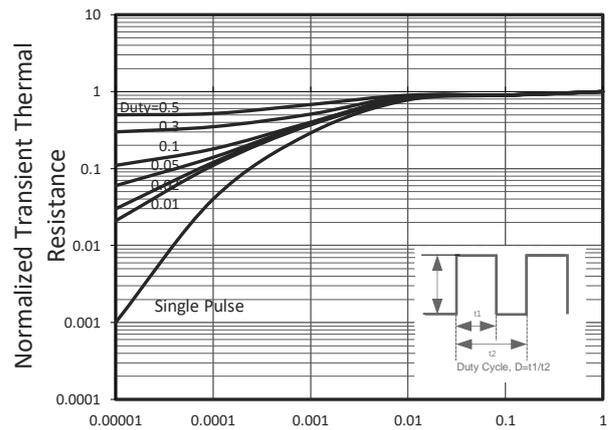
T_j-Junction Temperature(°C)
Gate Threshold Voltage



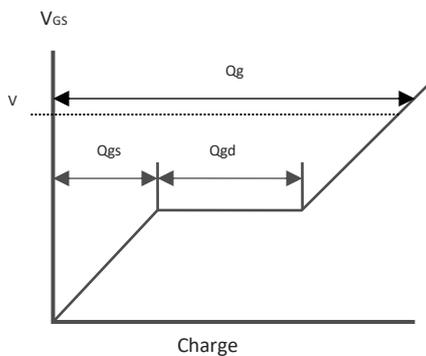
T_c-Case Temperature(°C)
Drain Current vs T_c



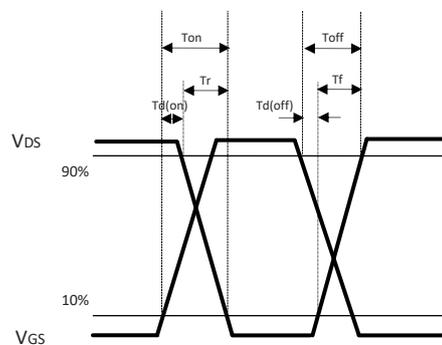
V_{ds} Voltage (V)
Maximum Safe Operation Area



Square Wave Pulse Duration(Sec)
Thermal Transient Impedance

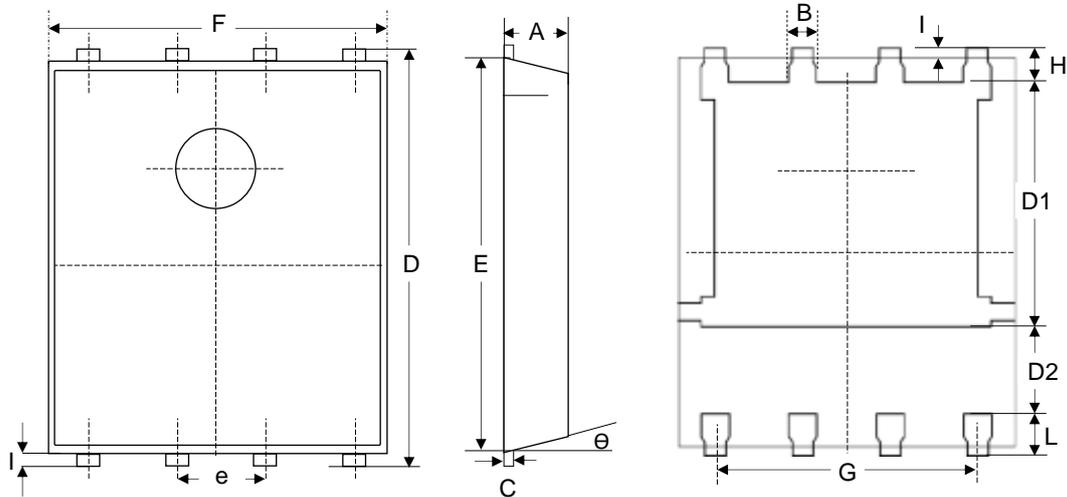


Gate Charge Waveform



Switching Time Waveform

DFN5X6A PACKAGE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.100	0.035	0.043
B	0.330	0.510	0.013	0.020
C	0.200	0.300	0.008	0.012
D	5.900	6.100	0.232	0.240
D1	3.380	3.780	0.133	0.149
D2	1.100		0.043	
E	5.700	5.800	0.224	0.228
e	1.270BSC.		1.270BSC.	
F	4.800	5.000	0.189	0.197
G	0.361	0.396	0.014	0.016
H	0.410	0.610	0.016	0.024
I	0.060	0.200	0.002	0.008
L	0.510	0.710	0.020	0.028
θ	0°	12°	0°	12°

Recommended Land Pattern

